

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10575093	MURAKATA ET AL.
	Examiner	Art Unit
	Loewe, Sun Jae Y	1626

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
STN structure	8/27/2007	sl
palm inventor (all inventors)	8/27/2007	sl

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner